Search Notes

_	Application/Control No.	Applicant(s)/Patent Under
	1001=010	Reexamination
	10815249	FUJIO ET AL.
	Examiner	Art Unit
	Douglas O Tran	2625

	SEARCHED		
Class	Subclass	Date	Examiner
358	1.15, 1.1, 1.9, 3.23, 3.27, 3.28, 518, 540	05/06/08	Dt

SEARCH NOTES			
Search Notes	Date	Examiner	
NPL (IEEE), East Search	05/06/08	Dt	

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
Same as above	Same as above	05/06/08	Dt		

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